



10-1504

Attorney's Docket No.: 17646-122001 / 20000253

IFW

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Francois Noirot-Nerin
Serial No. : 10/733,747
Filed : December 11, 2003
Title : SYSTEM AND METHOD FOR COMPARING OBJECTS

Art Unit : 2122
Examiner : Unknown

MAIL STOP AMENDMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

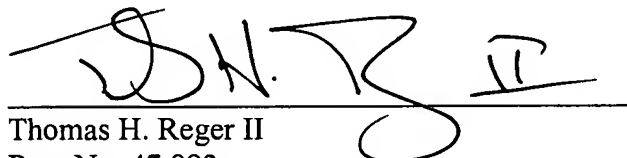
INFORMATION DISCLOSURE STATEMENT

Applicant submits the attached form PTO-1449. The present application was filed after June 30, 2003. Therefore, under the July 11, 2003 waiver of 37 C.F.R. §1.98(a)(2)(i) by the U.S. Patent and Trademark Office, copies of the U.S. patents listed on the attached PTO-1449 form are not enclosed.

This statement is being filed within three months of the filing date of the application or before the receipt of a first Office action on the merits. Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: October 14, 2004


Thomas H. Reger II
Reg. No. 47,892

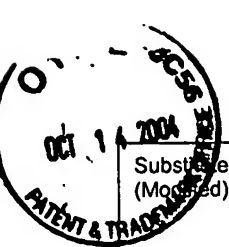
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Substitute Form PTO-1449
(Modified)U.S. Department of Commerce
Patent and Trademark OfficeAttorney's Docket No.
17646-122001Application No.
10/733,747**Information Disclosure Statement
by Applicant**

(Use several sheets if necessary)

(37 CFR §1.98(b))

Applicant
Francois Noirot-NerinFiling Date
December 11, 2003Group Art Unit
2122**U.S. Patent Documents**

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	5,717,924	02/10/1998	Kawai			
	AB	6,026,408	02/15/2000	Srinivasan et al.			
	AC	6,105,062	08/15/2000	Andrews et al.			
	AD	6,345,311	02/05/2002	Breslau et al.			
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
	AQ	
	AR	
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Date Considered

EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.